

Data Sheet July 1999 File Number 2294.3

# 12A, 200V, 0.500 Ohm, P-Channel Power MOSFET

This P-Channel enhancement mode silicon gate power field effect transistor is an advanced power MOSFET designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA17522.

## **Ordering Information**

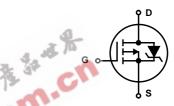
PART NUMBER	PACKAGE	BRAND
IRFP9240	TO-247	IRFP9240

NOTE: When ordering, use the entire part number.

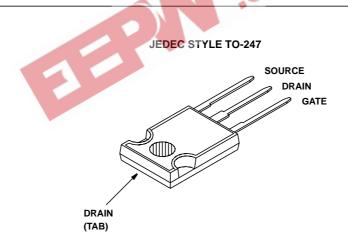
#### **Features**

- 12A, 200V
- $r_{DS(ON)} = 0.500\Omega$
- Single Pulse Avalanche Energy Rated
- · SOA is Power Dissipation Limited
- · Nanosecond Switching Speeds
- · Linear Transfer Characteristics
- · High Input Impedance

## Symbol







## **IRFP9240**

## **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

	IRFP9240	UNITS
Drain to Source Breakdown Voltage (Note 1)	-200	V
Drain to Gate Voltage ( $R_{GS} = 20k\Omega$ ) (Note 1)	-200	V
Continuous Drain Current	-12	Α
$T_{C}$ = 125 $^{\circ}$ C	-7.5	Α
Pulsed Drain Current (Note 3)	-48	Α
Gate to Source Voltage	±20	V
Maximum Power Dissipation	150	W
Linear Derating Factor	1.2	W/oC
Single Pulse Avalanche Energy Rating (Note 4)	790	mJ
Operating and Storage Temperature	-55 to 150	οС
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	300	οС
Package Body for 10s, See Techbrief 334	260	οС

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1.  $T_J = 25^{\circ}C$  to  $125^{\circ}C$ .

## $\textbf{Electrical Specifications} \hspace{0.5cm} \textbf{T}_{C} = 25^{0}\text{C}, \hspace{0.5cm} \textbf{Unless Otherwise Specified}$

PARAMETER	SYMBOL	TEST CON	DITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V (Figure 10)		-200	-	-	V
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-01-	-2.0	-	-4.0	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = Rated BV <sub>DSS</sub> , V <sub>GS</sub>	= 0V	-	-	25	μΑ
		$V_{DS} = 0.8 \text{ x Rated BV}_{DSS}$	$V_{GS} = 0V, T_J = 125^{\circ}C$	-	-	250	μΑ
On-State Drain Current (Note 2)	I <sub>D(ON)</sub>	V <sub>DS</sub> > I <sub>D(ON)</sub> x r <sub>DS(ON)MA</sub>	x, V <sub>GS</sub> = -10V	-12	-	-	Α
Gate to Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V		-	-	±100	nA
Drain to Source On Resistance (Note 2)	r <sub>DS(ON)</sub>	$I_D = -6.3A$ , $V_{GS} = -10V$ (Fig	gures 8, 9)	-	0.380	0.500	Ω
Forward Transconductance (Note 2)	9fs	$V_{DS} \le -50V$ , $I_{D} = -6.3A$ (Fig	gure 12)	3.8	5.7	-	S
Turn-On Delay Time	t <sub>d</sub> (ON)	V <sub>DD</sub> = -100V, I <sub>D</sub> ≈ -12A, R <sub>0</sub>		-	18	22	ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = -10V, R <sub>L</sub> = 7.6 $\Omega$ , (Figures 17, 18) MOSFET Switching Times are Essentially Indepen-		-	45	68	ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	dent of Operating Tempera		-	75	90	ns
Fall Time	t <sub>f</sub>	1		-	29	44	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q <sub>g(TOT)</sub>	$\begin{split} &V_{GS} = \text{-}10\text{V},  I_D = \text{-}12\text{A},  V_{DS} = 0.8 \text{ x Rated BV}_{DSS} \\ &I_{g(REF)} = \text{-}1.5\text{mA (Figures 14, 19, 20)} \\ &Gate  \text{Charge is Essentially Independent of Operating Temperature} \end{split}$		-	38	57	nC
Gate to Source Charge	Q <sub>gs</sub>			-	8	-	nC
Gate to Drain "Miller" Charge	Q <sub>gd</sub>			-	21	-	nC
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = -25V, V <sub>GS</sub> = 0V, f = 1MHz (Figure 11)		-	1400	-	pF
Output Capacitance	C <sub>OSS</sub>			-	350	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	140	-	pF
Internal Drain Inductance	L <sub>D</sub>	Measured From the Contact Screw on Header Closer to Source and Gate Pins to Center of Die	Modified MOSFET Symbol Showing the Internal Devices Inductances	-	5.0	-	nH
Internal Source Inductance	L <sub>S</sub>	Measured From the Source Pin, 6mm (0.25in) From Header to Source Bonding Pad	G G G S S	-	12.5	-	nH
Thermal Resistance Junction to Case	$R_{ heta JC}$		•	-	-	0.83	oC/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Free Air Operation		-	-	30	oC/W

#### **IRFP9240**

### **Source to Drain Diode Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I <sub>SD</sub>	Modified MOSFET Symbol	-	-	-12	Α
Pulse Source to Drain Current (Note 3)	I <sub>SDM</sub>	Showing the Integral Reverse P-N Junction Rectifier	)	-	-48	A
Source to Drain Diode Voltage (Note 2)	V <sub>SD</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = -12A$ , $V_{GS} = 0V$ , (Figure 13)		-	-1.5	V
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = -11A$ , $dI_{SD}/dt = 100A/\mu s$		210	-	ns
Reverse Recovery Charge	Q <sub>RR</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = -11A$ , $dI_{SD}/dt = 100A/\mu s$		2.0	-	μC

#### NOTES:

- 2. Pulse test: pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2\%$ .
- 3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4.  $V_{DD}$  = 50V, starting  $T_J$  = 25°C, L = 8.2mH,  $R_G$  = 50 $\Omega$ , peak  $I_{AS}$  = 12A (Figures 15, 16).

## Typical Performance Curves Unless Otherwise Specified

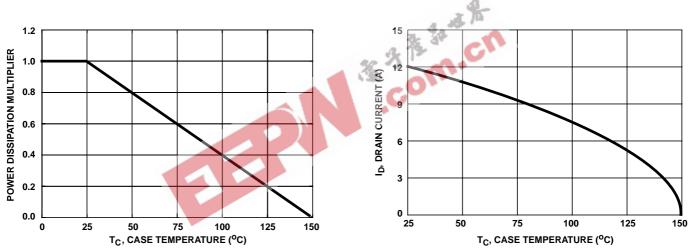


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

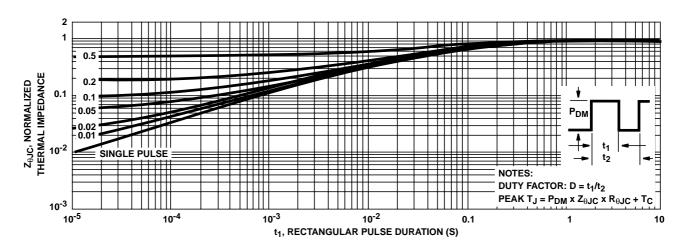
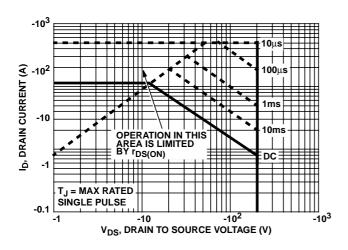


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

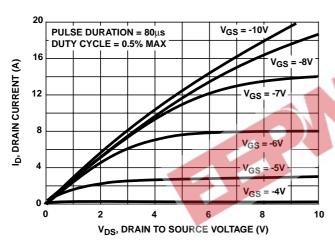
## Typical Performance Curves Unless Otherwise Specified (Continued)



20 PULSE DURATION =  $80\mu s$ V<sub>GS</sub> = -10V DUTY CYCLE = 0.5% MAX  $V_{GS} = -8V$ V<sub>GS</sub> = -7V 16 ₹ ID, DRAIN CURRENT 12  $V_{GS} = -6V$ 8  $V_{GS} = -5V$  $V_{GS} = -4V$ 0 0 60 100 40 V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V)

FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

FIGURE 5. OUTPUT CHARACTERISTICS



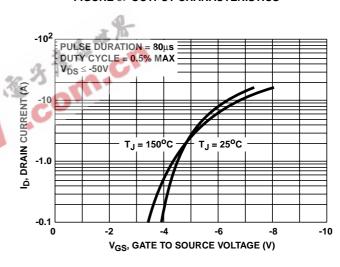
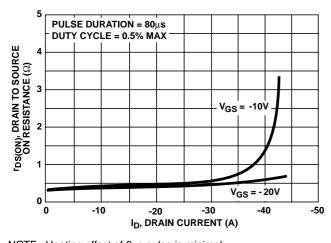
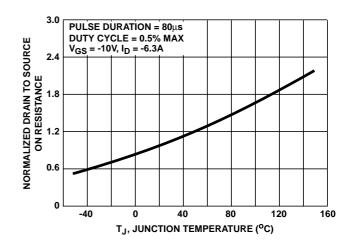


FIGURE 6. SATURATION CHARACTERISTICS

FIGURE 7. TRANSFER CHARACTERISTICS



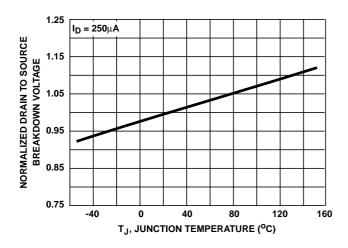


NOTE: Heating effect of  $2\mu s$  pulse is minimal.

FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

## Typical Performance Curves Unless Otherwise Specified (Continued)



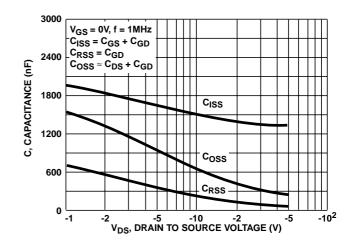
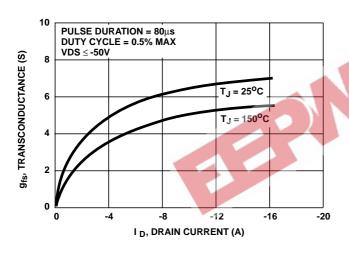


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



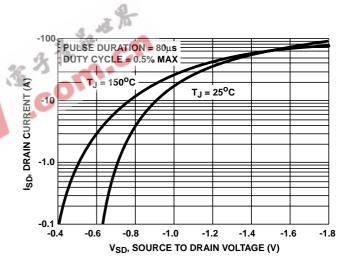


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

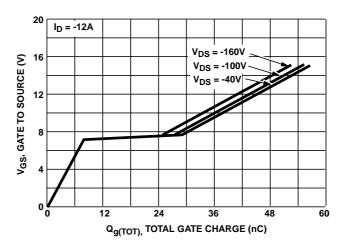
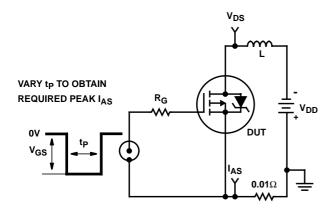


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

### Test Circuits and Waveforms



V<sub>DD</sub> t<sub>AV</sub> V<sub>DS</sub>

FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

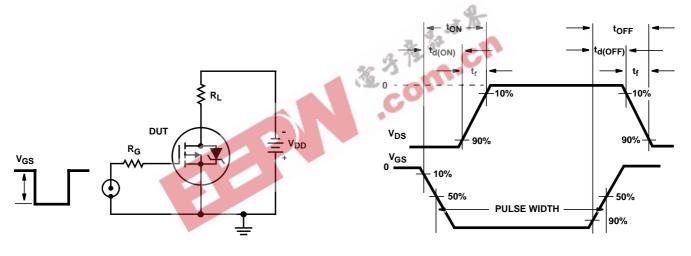


FIGURE 17. SWITCHING TIME TEST CIRCUIT

FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

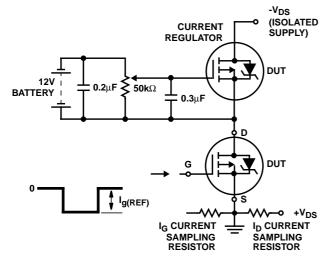


FIGURE 19. GATE CHARGE TEST CIRCUIT

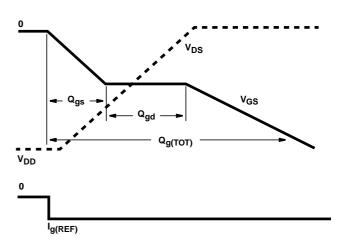


FIGURE 20. GATE CHARGE WAVEFORMS



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#### Sales Office Headquarters

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Intersil Corporation
P. O. Box 883, Mail Stop 53-204
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TEL: (407) 724-7000 FAX: (407) 724-7240

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Intersil SA Mercure Center 100, Rue de la Fusee 1130 Brussels, Belgium TEL: (32) 2.724.2111 FAX: (32) 2.724.22.05

## ASIA

Intersil (Taiwan) Ltd.
7F-6, No. 101 Fu Hsing North Road
Taipei, Taiwan
Republic of China
TEL: (886) 2 2716 9310
FAX: (886) 2 2715 3029